Diamond Strip Detectors for Charged Particle Tracking

Joseph Tabeling



Outline

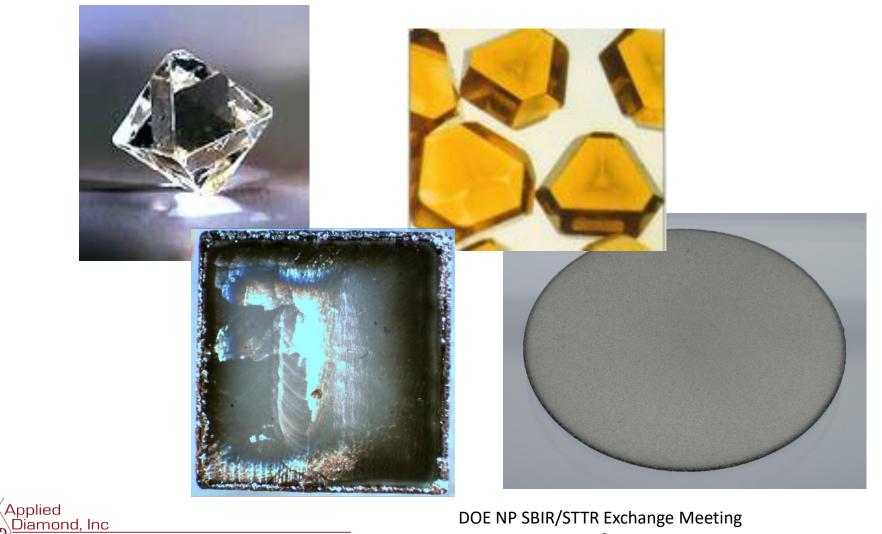
- A Bit about Applied Diamond
- Topic and Challenges
- Progress to-date
 - Diamond Growth
 - Material Uniformity
 - Material Removal
 - Packaging

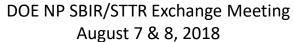
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Commercialization

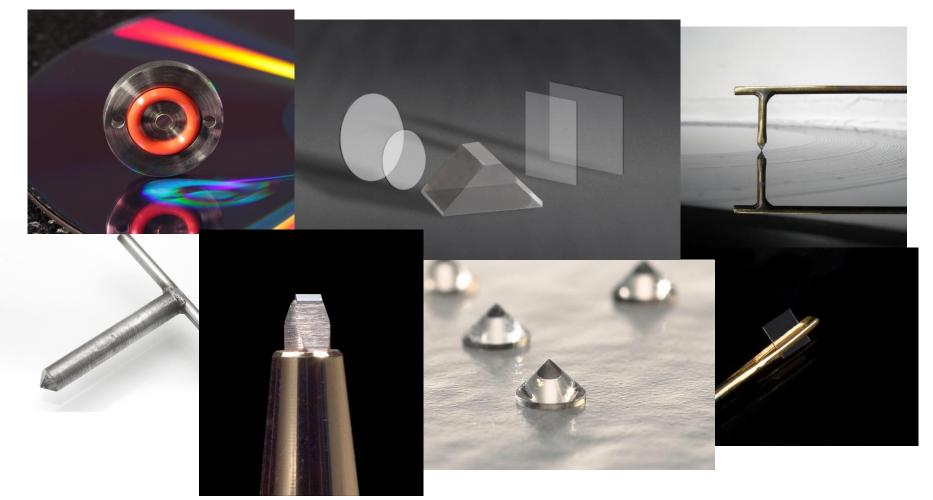
Diamond – Types and Sources





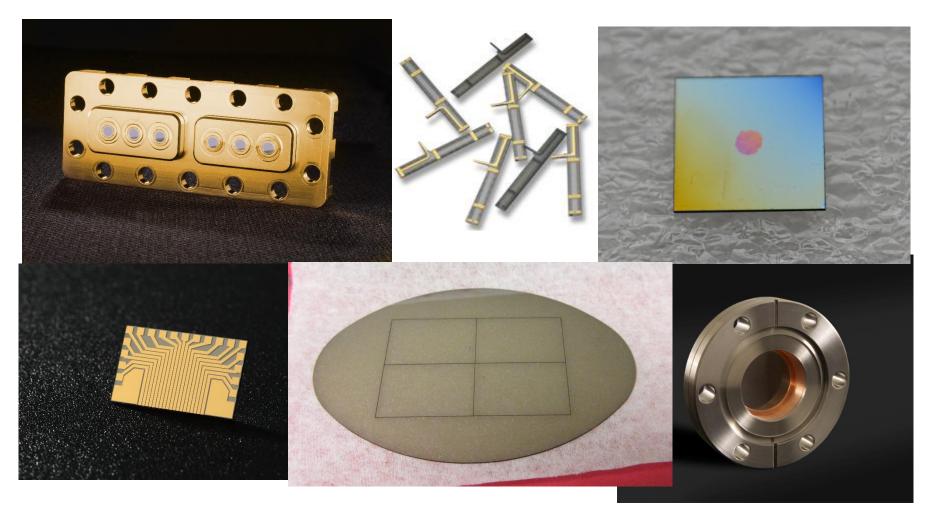
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Diamond – Finished Products (single crystal)



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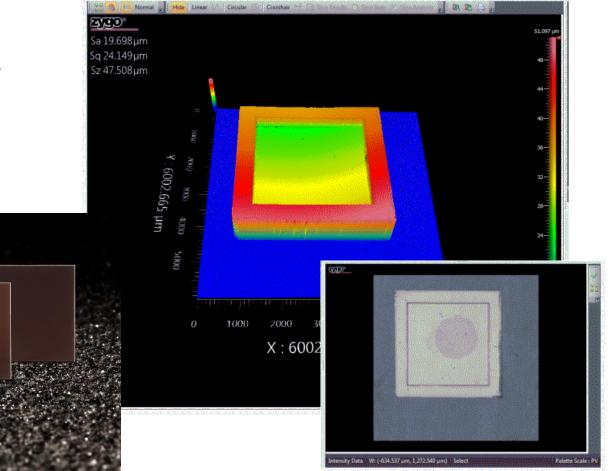
Diamond – Finished Products (polycrystalline)





Diamond – New Capabilities

- Doping w/ boron, nitrogen
- Dry etching w/ RIE/ICP





Solicitation Topic and Challenges

24b. Grant applications are sought to develop advances in the general field of solid-state devices for tracking of charged particles and neutrons, such as silicon drift, strip, and pixel detectors, along with 3D silicon devices. Approaches of interest include:

5. Diamond detector or other radiation hard strip detector with strip size of 500 μ m or less and at least 192 strip giving a total length of at least 4.8 cm long.

Monitoring electron beam polarization via Comptonscattered electron detection.

Distance from detector to electronics means more signal is needed:

- thicker detector
- remove defect-laden nucleation layer

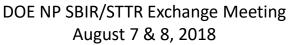
Uniform performance over larger area

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Contact pitch of 240 μm – 220 μm wide / 20 μm spaces



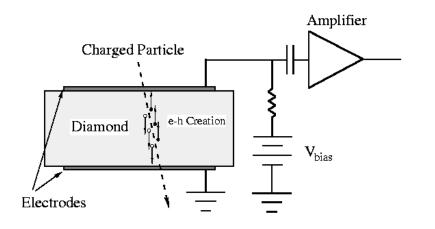


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Why Diamond?

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Solid-State Ionization Chamber

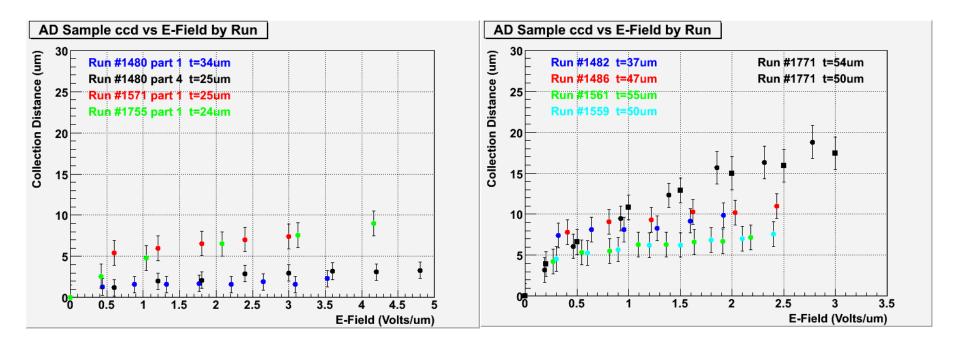
- 36 e-h pairs created per μm of diamond traversed per MIP
- Charges drift responding to bias voltage creating measured signal
- Trapped by defects in material so charge collection distance is average distance an e-h pair drift apart
- Radiation tolerance tested and found superior with wide range of particles/conditions.
- Smaller dielectric constant provides lower capacitance and lower noise.
- Excellent insulator so no leakage current even under high electric fields.

Diamond Growth Progress

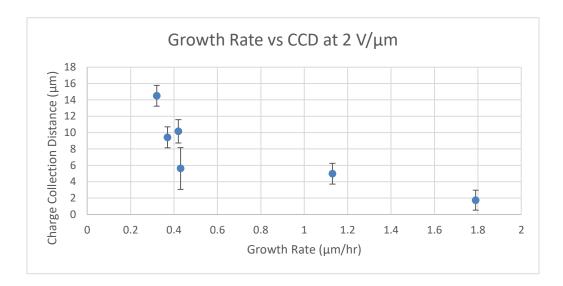
Results on thin films

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Diamond Growth Progress



- All samples are 100 µm thick
- Slower is better

- Despite problems in growth, thicker is always better
- 500 μm at 0.33 μm/hr = 1500 hrs!!!

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Uniformity of Performance

Rotating Stage

Substrate Holder Design

100 90

50 40

30

y. L.x

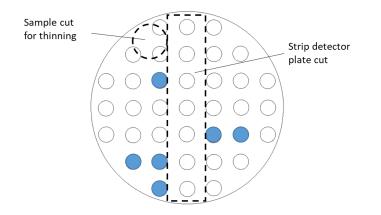
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Surface: Temperature (degC)

Thickness vs. Position of 570 um Film After **Rotating Stage** 850 Thickness (um) 750 650 550 X-axis 450 Y-axis 350 20 -30 -20 -10 0 10 30 Position Thickness vs. Position of 400 um Film with Modified Puck 600 Thickness (um) 500 X-axis 300 -Y-axis 200 -25 -20 -15 -10 -5 0 5 10 15 20 25 Position

Area Dependence of CCD



48x15mm diamond plate with metal contacts

Ο	0	0	0	0	0	0
0	0	0	0	0	0	0
000	0	0	0	0	0	0

CCD, relative %

114	97	91	103	98	102	95
111	92	97	93	113	105	95
112	88	93	90	99	114	99

- Raman showed few locations with NV centers – cut samples avoiding those spots.
- Added contacts and measured CCD vs. location on strip detector blank.

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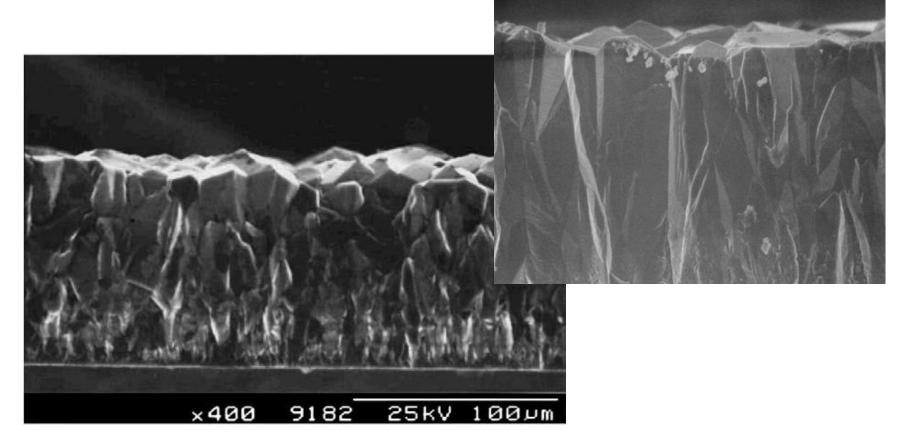
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Thickness, relative %

110	108	105	102	100	97	94
108	106	103	100	98	95	92
105	103	100	97	95	92	90

Material Removal Progress

Why remove material?

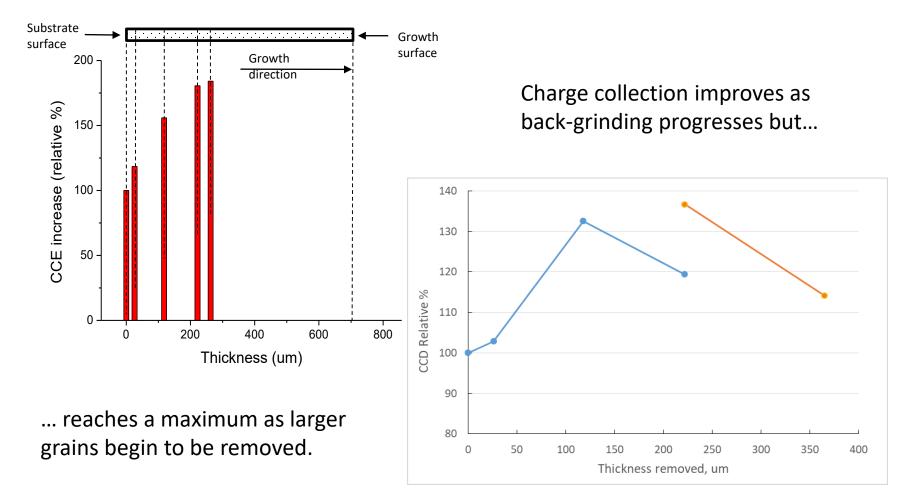




Material Removal Progress

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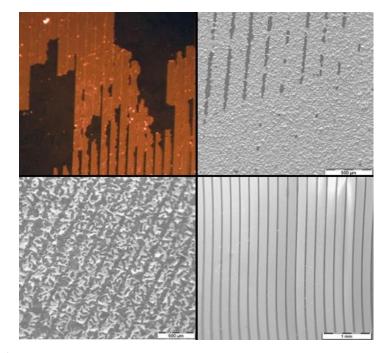


Packaging Progress – Lithography

Various lithography methods attempted.

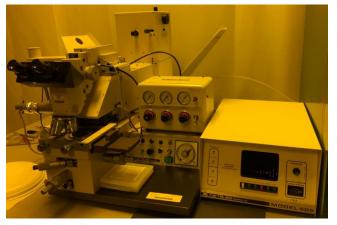
- negative or etch process gives desired results.

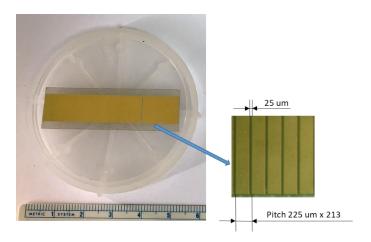
- expanded process to larger areas.



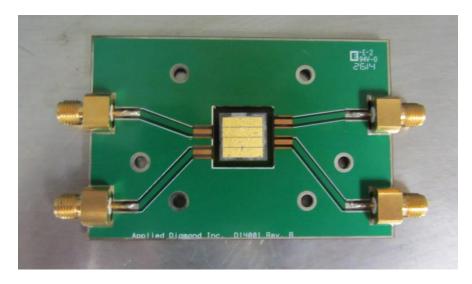
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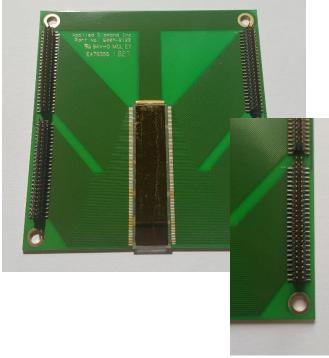


Packaging Progress



Incorporation of passives, preamp circuit?

- Board Materials
- Soldering Improvements
- Wirebonding Challenges





Commercialization Strategy

For scientific customers:

- Offer both poly and sc CVD diamond for detector applications
- Develop credibility with results of characterization testing
- Provide standard and custom packaging options
- Partner in development of new detector products

For industrial customers:

- Provide resource to educate and ease adoption of diamond
- Develop one-stop source for detectors using diamond



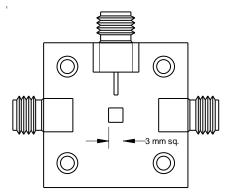
Current Commercialization Projects

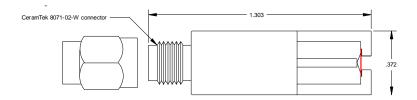
Packaged Detectors

- Charged particle detector

 (in heavy neutron/gamma flux environment)
- Mosaic delta-E detector for slow, heavy ions (time-of-flight, intermediate-energy relativistic ions)
- Protons/Tritons/Alphas (in fusion energy research)
- X-ray fluorescence microscope (intensity indicator, normalization of signals collected from samples)
 - 10¹¹ photons/sec at 4.5 25 keV









Current Commercialization Projects

Material Sales

- INFN 100 electron bunches with 0.5 GeV energies
 - 2 cm sq / 50 μm thick / 5 10 μm CCD
- BNL beam position monitors
 - 4.5 mm sq / 50 μ m thick / single crystal
- GSI

beilggA

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- 2 cm sq / 100 μm thick / 15 – 20 μm CCD

Processing Services

- Contact deposition on customer-supplied materials
 - ESRF high energy particle detectors
- Selective thinning of customer-supplied materials
 - BNL, GSI, Synchrotron Soleil beam position monitors

Conclusions

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• Have a process for growing thick diamond films for detector applications.

• Have quantitatively evaluated removal of defective substrate-side material to maximize CCD.

• Have actively begun work to improve performance uniformity across larger detector areas.

- Have demonstrated required contact pitch and spacing.
- Have an in-house low volume custom packaging capability.
- Have sales of diamond material, services and packaged detectors.

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